

SRM Institute of Science and Technology Faculty of Engineering and Technology

SET-B

DEPARTMENT OF ECE

SRM Nagar, Kattankulathur – 603203, Chengalpattu District, Tamilnadu

Academic Year: 2022-2023 (EVEN)

Test: CLAT-3 Date: 04/05/23

Course Code & Title: 18ECC302J-Microwave and Optical Communication

Year & Sem: III /VI

Duration: 10:30-12:10 PM

Max. Marks: 50

	18ECC302J - Microwave & Optical Communications	Program Outcomes (POs)														
			Graduate Attributes						PSO							
S. No.	Course Outcomes (COs)	1	2	3	4	5	6	7	8	9	10	11	12	1	2	3
1	Demonstrate the knowledge on the theory of microwave transmission, microwave generators and associated components.	3	-	-	3	-	-	-	-	-	-	-	-	-	-	1
2	Analyse the microwave passive devices and components.	-	2	-	3	-	-	-	-	-	-	-	-	2	-	-
3	Incorporate microwave measurements and associated techniques with equipment	-	-	3	2	-	-	-	-	-	1	-	-	-	-	3
4	Gain knowledge of the fundamentals on light transmission through fiber	-	3	-	2	-	-	-	-	1	-	-	-	-	-	1
5	Develop a basic optical communication system.	-	3	-	-	3	-	-	-	-	-	-	-	2	-	-
6	Implement the working principle of microwave components, microwave measurements, optical sources, detector and fibers	-	-	3	-	3	-	-	-	-	-	-	-	-	-	3

Q. No	Answer		BL	CO	PO
110	Part – A (5 × 10 = 50 Marks)				
	Instructions: Answer any FIVE Questions.				
1	i) a) 0.344	1	4	4	2
	ii) The identified source is Vertical Cavity Surface Emitting Laser- VCSEL.(1 mark)	9	3	4	2
	Brago reflectors Metal (positive contact) Active region with quantum wells High index Low index Cow index				
	(3 marks) Vertical cavity means the structure (cavity) providing laser feedback is arrange				
	in the vertical direction. Surface emitting means the laser beam is emitted				
	perpendicular to the wafer. Semiconductor heterostructure forms an active				
	region. Several quantum wells are made within this active region to enhance				
	light gain. This region is placed between Bragg reflectors- the stacks of layers				
	with alternate high and low refractive index material. Each layer is $\lambda/4$ thick				

	and made from GaAs (n=3.6) and AlAs (n=2.9). These layer work like high reflective mirror providing positive feedback (2 marks) Advantages • Size of the resonant cavity is very small resulting in huge spacing between two adjacent longitudinal modes • Only one mode can be within gain curve • Operates in single mode regime • Very small dimensions (cavity and diameter of active region is about 1 to 5µm and thickness is 25nm) • Can fabricate many diodes on one substrate • Low power consumption and high switching speed • High current density at low current value • Short lifetime leading to high modulation bandwidth • VCSEL diode radiates a circular output beam in contrast to that radiated by edge emitting lasers • Fabrication technology is very similar to that for electronic chips (3 marks)				
2	i) d) 32	1	4	4	2
	ii) PIN diode (1 mark) Construction (3 marks) The PIN photodiode is structured with p and n regions separated by a lightly n-doped intrinsic (i) region. Incident photon with energy ≥ band-gap energy of the photodiode will generate free electron-hole pairs, known as photo-carriers. The high electric field present in the depletion region causes the carriers to separate and be collected across the reverse-biased junction. This gives rise to a photo-current flow in an external circuit, with one electron flowing for every carrier pair generated. In the absence of light, PIN photodiodes behave electrically just like an ordinary rectifier diode. If forward biased, they conduct large amount of current. **Photodiode** Photodiode** Photovoltaic Mode** Photovoltaic Mode* No bias is applied to the detector. In this case, the detector works very slow and output is approximately logarithmic to the input light level. Real world fiber optic receivers never use the photovoltaic mode. Photoconductive Mode* The detector is reversed biased. The output in this case is a current that is very linear with the input light power. The intrinsic region somewhat improves the sensitivity of the device. It does not provide internal gain. The combination of different semiconductors operating at different wavelengths allow the selection of material capable of responding to the desired operating wavelength.	9	3	4	2

Characteristic Parameters (3 marks) Diffusion Length: As the charge carriers flow through the material, some electron-hole pairs will recombine and disappear. On the average, the charge carriers move a diffusion length L_n or L_p for electrons and holes, respectively. Carrier Life time: The time it takes for an electron or hole to recombine is known as the carrier lifetime and is represented by τ_n and τ_p , respectively. The lifetimes and the diffusion lengths are related by $L_n = (D_n \tau_n)^{1/2}$ and $L_p = (D_p \tau_p)^{1/2}$ where D_n and D_p are the electron and hole diffusion coefficients, expressed in units of cm²/sec. Optical power absorbed Optical radiation is absorbed in the semiconductor material according to the exponential law $P(x) = P_0[1 - \exp(-\alpha_s(\lambda)x)]$ Here, $\alpha_s(\lambda)$ is the absorption coefficient at wavelength λ , P_0 is the incident optical power level, and $P(x)$ is the optical power absorbed in a distance x .				
ii) The phenomenon where signal distortion happens due to broadening of the pulse is called dispersion (1 mark) Signal Distortion/ Dispersion Polarization-mode Dispersion (3 marks) Intramodal Dispersion or Chromatic Dispersion takes place within a single mode. It depends on the wavelength, its effect on signal distortion increases with the spectral width of the light source. Spectral width is approximately 4 to 9 percent of a central wavelength. Two main causes of intramodal dispersion are as: Material Dispersion This refractive index property causes a wavelength dependence of the group velocity of a given mode; that is, Pulse spreading occurs even when different wavelength follow the same path. Material dispersion can be reduced: Either by choosing sources with narrower spectral output widths or by operating at longer wavelengths.	1 9	4 3	4 4	2 2

	Waveguide Dispersion				
	It causes pulse spreading because only part of the optical power propagation along a fiber is confined to core. Dispersion arises because the fraction of light power propagating in the cladding travels faster than the light confined to core. Single mode fiber confines only 80 percent of the power in the core for V values around 2. The amount of waveguide dispersion depends on the fiber design. (5 marks)				
4	i) b) Rise time budget	1	1	5	2
	ii) The link power budget is an "accounting" procedure in which one calculates how much power can be lost between the transmitter and the receiver for a given receiver sensitivity (which depends on the bit rate) and transmitter power output. The resulting budget is allocated to connector losses, splice losses, fibre losses and a safety margin (system margin).dB and dBm units are used in the link power budget (2 marks)	5	3	5	2
	Considering a simple point-to-point-link (without amplifier), we find the following component power losses $k=P_{out}/P_{in}$: - Attenuation losses of the fiber (proportional to the fiber length L, $k_{taser}=e^{-uL}$) - Coupling losses (input) Laser-Fiber (k_{LF}) - Insertion loss of an external modulator (k_{MOD}) (optional) - Total Fiber-Splice losses (k_{SPLICE} , mostly proportional to L) - Coupling losses (output) Fiber-Photodetector (k_{PD})				
	- Amplification in optical amplifiers (G_{tot}) - Responsivity of the photodiode (R)				
	$P_{s,in}$ is the modulated optical power emitted by the source. We determine the power on the receiving photodiode as P_{out} : $\frac{P_{out} = P_{s,in}(0) k_{ptor}(L) k_{LF} k_{MOD} k_{SPLICE} k_{PD} G_{tor} = P_{rec}(L) > P_{rec,min}(BER, B_{ch})}{with}$				
	$P_{out} = P_{S,in} e^{-\alpha_{lows} L} e^{-\alpha_{lows} L} with \alpha_{loss} = \frac{1}{L} ln \left(k_{LF} k_{MOD} k_{SPLICE} k_{PD} G_{loc} \right) (equivalent \ loss \ per \ unit \ length)$				
	α _{loss} are local losses, represented formally as distributed losses over the distance L. Depending on 1) the requested BER 2) the necessary signal bandwidth B _{ch} 3) and the noise properties of the receiver				
	the receiver is characterized by its sensitivity , resp. a minimal optical power P _{rec.min} required at its input (P _{out} > P _{rec.min}). (3 marks)				
	iii)	4	2	5	2
	$T_{\text{syst}} = 1.1(T_{\text{S}}^2 + T_{\text{n}}^2 + T_{\text{c}}^2 + T_{\text{D}}^2)^{\frac{1}{2}}$ = 1.1(8 ² + (8 × 5) ² + (8 × 1) ² + 6 ²) ^{\frac{1}{2}} = 46.2 ns				
	Hence the maximum bit rate for the link using an NRZ format is given by Eq. (12.51) where:				
	$B_{\rm T}({\rm max}) = \frac{0.7}{T_{\rm syst}} = \frac{0.7}{46.2 \times 10^{-9}} \approx 15.2 \text{ Mbit s}^{-1}$				
5	i) b) 31	1	4	5	2
	ii)Radio frequency (RF) signals at microwave and millimetre-wave frequencies are used in applications such as radars, satellite links, broadband terrestrial radios, and cable television networks. Traditionally these RF systems used wireless or coaxial cable links for transporting the microwave signals from a receiving element (Ex. an antenna) to a signal processing centre, which could be located hundreds of meters away. The methods for transmitting microwave analog signals over an optical fiber link have become known as RF-over-fiber techniques. (1 mark)	5	3	5	2
	Architecture (4 marks)				



